Document Title

4M x 16 bit Pseudo SRAM Specification

Revision History

Revision No.	History	Date	Remark
0.0	-. Initial Draft	Feb. 20 2009	Preliminary

Emerging Memory & Logic Solutions Inc.
3F Korea Construction Financial Cooperative B/D, 301-1 Yeon-Dong, Jeju-Si, Jeju-Do, Rep.of Korea Zip Code : 690-717
Tel : +82-64-740-1700 Fax : +82-64-740-1749~1750 / Homepage : www.emlsi.com

4Mb x16 Pseudo Static RAM Specification

GENERAL DESCRIPTION

The EM7644SP16xP is 67,108,864 bits of Pseudo SRAM which uses DRAM type memory cells, but this device has refresh-free operation and extreme low power consumption technology. Furthermore the interface is compatible to a low power Asynchronous type SRAM. The EM7644SP16xP is organized as 4,194,304 Words x 16 bit.

FEATURES

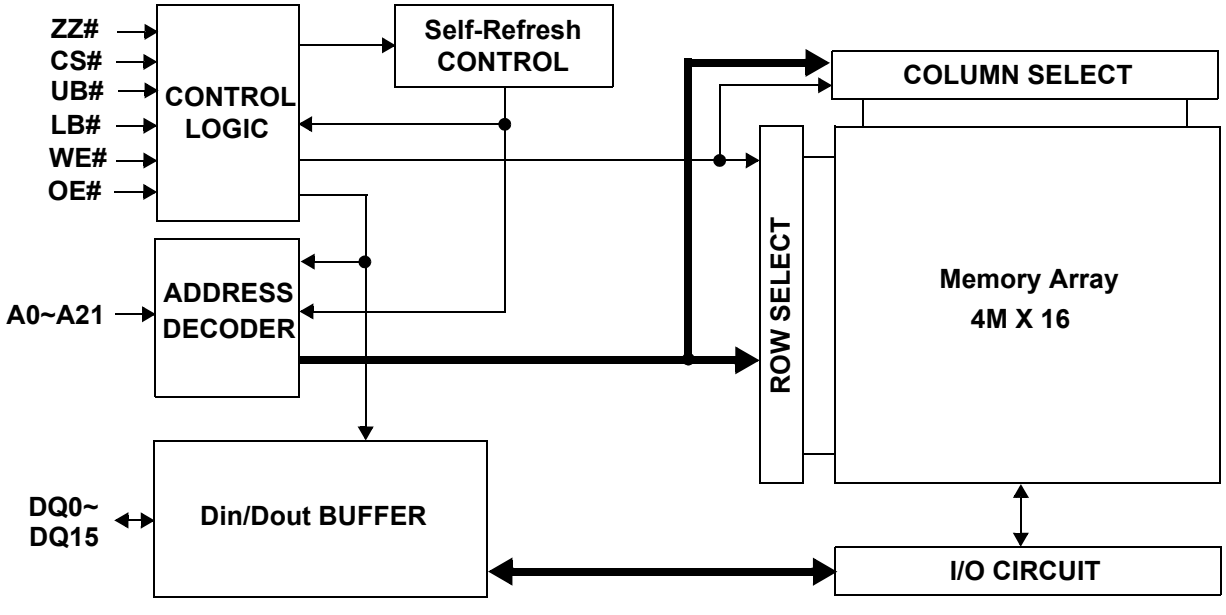
- Organization :4M x16
- Power Supply Voltage : 1.7 ~ 1.95V
- Separated I/O power(VccQ) & Core power(Vcc)
- Three state outputs
- Byte read/write control by UB# / LB#
- Auto-TCSR for power saving
- Package type : 48-FPBGA 6.0x7.0
- Operating Temperature
  . Extended : -25℃ ~ 85℃
  . Wireless : -30℃ ~ 85℃
  . Industrial : -40℃ ~ 85℃

- EM7644SP16LP support 8 page mode & DPD
- EM7644SP16MP support 8 page mode & Non-DPD
- EM7644SP16NP support 16 page mode & DPD
- EM7644SP16PP support 16 page mode & Non-DPD
- EM7644SP16RP support Non-page mode & DPD
- EM7644SP16SP support Non-page mode & Non-DPD

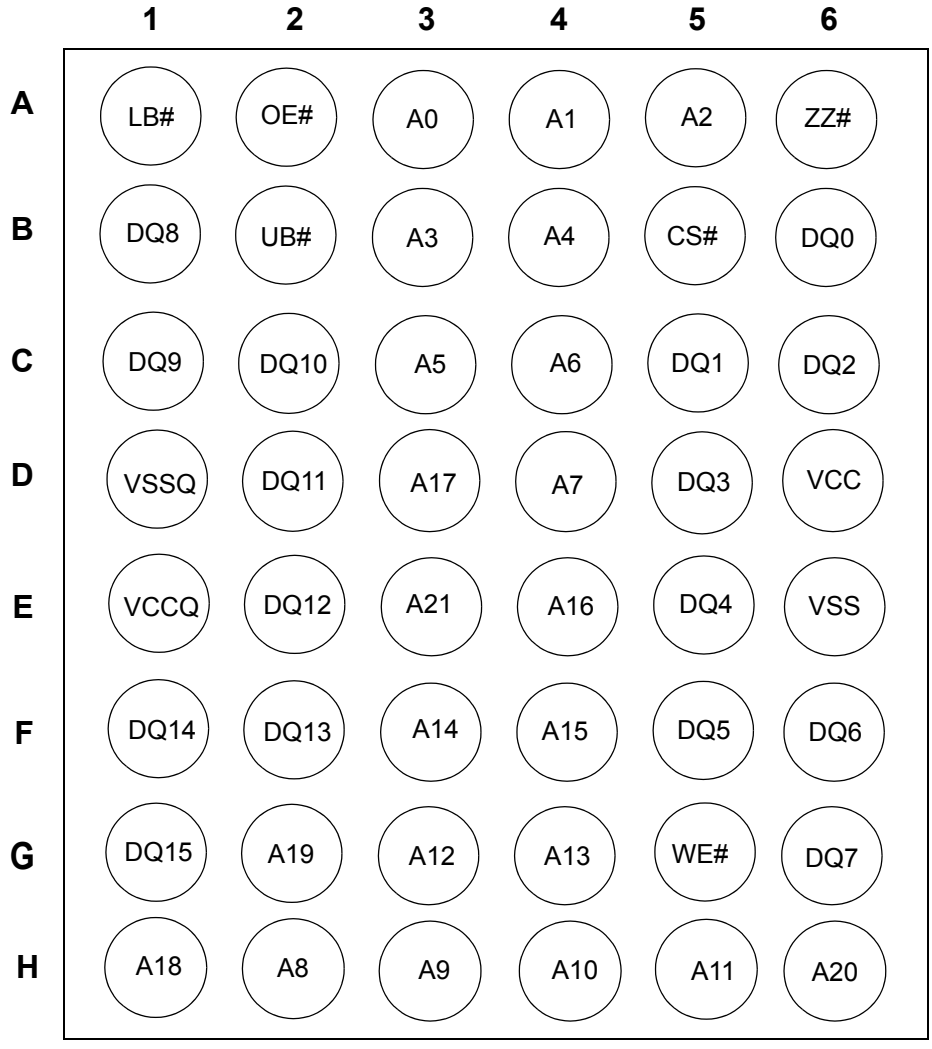
PRODUCT FAMILY

Part Number	Operating Temp.	Power Supply	Speed (t_{RC})	Power Dissipation		
				Standby (I_{SB}, Max.)	Operating I_{CC} (Max.)	
					I_{CC1} (f = 1MHz)	I_{CC2} (f = f_{max})
EM7644SP16xP-70LF	-25℃ to 85℃	1.7V to 1.95V	70ns	TBD	5mA	50mA
EM7644SP16xP-70LFW	-30℃ to 85℃	1.7V to 1.95V	70ns	TBD	5mA	50mA
EM7644SP16xP-70LFI	-40℃ to 85℃	1.7V to 1.95V	70ns	TBD	5mA	50mA

FUNCTION BLOCK DIAGRAM



PIN DESCRIPTION (48-FBGA-6.00x7.00)



TOP VIEW (Ball Down)

Name	Function	Name	Function
CS#	Chip select input	LB#	Lower byte ($DQ_{0\sim7}$)
OE#	Output enable input	UB#	Upper byte ($DQ_{8\sim15}$)
WE#	Write enable input	VCC	Power supply
ZZ#	Low power control	VCCQ	I/O power supply
DQ_{0-15}	Data in-out	VSS(Q)	Ground
A_{0-21}	Address inputs	NC	No connection
DNU	Do not use		

Note: ZZ# pin is replaced to NC pin in EM7644SP16MP, EM7644SP16PP, EM7644SP16SP.

ABSOLUTE MAXIMUM RATINGS [1)]

Parameter		Symbol	Ratings	Unit
Voltage on Any Pin Relative to Vss		V_{IN}, V_{OUT}	-0.2 to V_{CCQ}+0.3	V
Voltage on Vcc supply relative to Vss		V_{CC}, V_{CCQ}	-0.2[2)] to 2.5	V
Power Dissipation		P_D	1.0	W
Storage Temperature		T_{STG}	-65 to 150	°C
Operating Temperature	Extended	T_A	-25 to 85	°C
	Wireless		-30 to 85	°C
	Industrial		-40 to 85	°C

1. Stresses greater than those listed above "Absolute Maximum Ratings" may cause permanent damage to the device. Functional operation should be restricted to recommended operating condition. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Undershoot at power-off : -1.0V in case of pulse width ≤ 20ns

FUNCTIONAL DESCRIPTION

CS#	ZZ#	OE#	WE#	LB#	UB#	$DQ_{0\sim7}$	$DQ_{8\sim15}$	Mode	Power
H	H	X	X	X	X	High-Z	High-Z	Deselected	Stand by
X	L	X	X	X	X	High-Z	High-Z	Deselected	Low Power Mode*[2)]
L	H	H	H	L	X	High-Z	High-Z	Output Disabled	Active
L	H	H	H	X	L	High-Z	High-Z	Output Disabled	Active
L	H	L	H	L	H	Data Out	High-Z	Lower Byte Read	Active
L	H	L	H	H	L	High-Z	Data Out	Upper Byte Read	Active
L	H	L	H	L	L	Data Out	Data Out	Word Read	Active
L	H	X	L	L	H	Data In	High-Z	Lower Byte Write	Active
L	H	X	L	H	L	High-Z	Data In	Upper Byte Write	Active
L	H	X	L	L	L	Data In	Data In	Word Write	Active

Note:
1. X means don't care. (Must be low or high state)
2. This Low Power mode is supported in EM7644SP16LP, EM7644SP16NP & EM7644SP16RP.

RECOMMENDED DC OPERATING CONDITIONS

Parameter	Symbol	Min	Typ	Max	Unit
Supply voltage	V_{CC}	1.7	1.8	1.95	V
	V_{CCQ}	1.7	1.8	1.95	V
Ground	V_{SS}, V_{SSQ}	0	0	0	V
Input high voltage	V_{IH}	V_{CCQ} - 0.4	-	V_{CCQ} + 0.2[1)]	V
Input low voltage	V_{IL}	-0.2[2)]	-	0.4	V

1. Overshoot: Vcc +1.0 V in case of pulse width ≤ 20ns
2. Undershoot: -1.0 V in case of pulse width ≤ 20ns
3. Overshoot and undershoot are sampled, not 100% tested.

CAPACITANCE[1)] (f =1MHz, T_A=25°C)

Item	Symbol	Test Condition	Min	Max	Unit
Input capacitance	C_{IN}	V_{IN}=0V	-	8	pF
Input/Output capacitance	C_{IO}	V_{IO}=0V	-	8	pF

1. Capacitance is sampled, not 100% tested

DC AND OPERATING CHARACTERISTICS

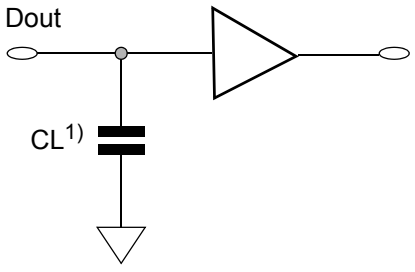
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Input leakage current	I_{LI}	V_{IN}=V_{SS} to V_{CCQ} , V_{CC}=V_{CCmax}	-1	-	1	uA
Output leakage current	I_{LO}	CS#=V_{IH} , ZZ#=V_{IH} , OE#=V_{IH} or WE#=V_{IL} , V_{IO}=V_{SS} to V_{CCQ} , V_{CC}=V_{CCmax}	-1	-	1	uA
Average operating current	I_{CC1}	Cycle time = 1us, I_{IO}=0mA, 100% duty, CS#≤0.2V, ZZ#≥V_{CCQ}-0.2V, V_{IN}≤0.2V or V_{IN}≥V_{CCQ}-0.2V	-	-	5	mA
	I_{CC2}	Cycle time = Min, I_{IO}=0mA, 100% duty, CS#=V_{IL}, ZZ#=V_{IH}, V_{IN}=V_{IL} or V_{IH}	-	-	50	mA
Page access operating current	I_{CCP}	tPC = Min,CS#=V_{IL}, ZZ#=V_{IH} , I_{IO}=0mA, Page add. cycling.	-	-	25	mA
Output low voltage	V_{OL}	I_{OL} = 0.5mA, V_{CC}=V_{CCmin}	-	-	0.2*V_{CCQ}	V
Output high voltage	V_{OH}	I_{OH} = -0.5mA, V_{CC}=V_{CCmin}	0.8*V_{CCQ}	-	-	V
Standby current (CMOS)	I_{SB}	CS#,ZZ#≥V_{CCQ}-0.2V, Other inputs = 0 ~ V_{CCQ} (Typ. condition : V_{CC}=1.8V @ 25°C) (Max. condition : V_{CC}=1.95V @ 85°C)	-	-	TBD	uA

1. Maximum Icc specifications are tested with V_{CC} = V_{CCmax}.

AC OPERATING CONDITIONS

Test Conditions (Test Load and Test Input/Output Reference)

Input Pulse Level : 0.2V to V_{CCQ}-0.2V
Input Rise and Fall Time : 5ns
Input and Output reference Voltage : $V_{CCQ}/2$
Output Load (See right) : $CL^{1)}$ = 30pF



1. Including scope and Jig capacitance

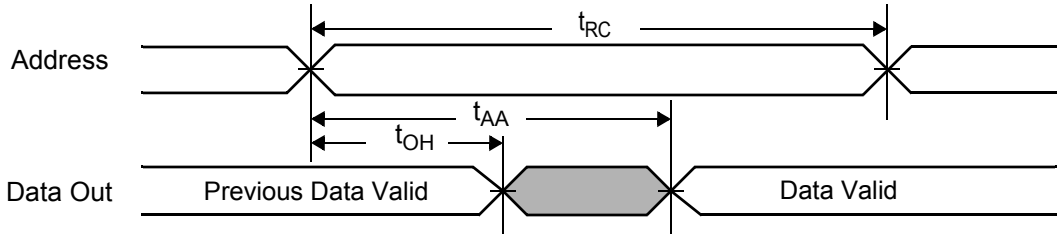
AC CHARACTERISTICS

Parameter List		Symbol	Speed		Unit
			Min	Max	
Read	Read Cycle Time	t_{RC}	70	10k	ns
	Address access time	t_{AA}	-	70	ns
	Chip enable to data output	t_{CO}	-	70	ns
	Output enable to valid output	t_{OE}	-	25	ns
	UB#, LB# enable to data output	t_{BA}	-	25	ns
	Chip enable to low-Z output	t_{LZ}	10	-	ns
	UB#, LB# enable to low-Z output	t_{BLZ}	0	-	ns
	Output enable to low-Z output	t_{OLZ}	0	-	ns
	Chip disable to high-Z output	t_{HZ}	0	20	ns
	UB#, LB# disable to high-Z output	t_{BHZ}	0	20	ns
	Output disable to high-Z output	t_{OHZ}	0	20	ns
	Output hold from Address change	t_{OH}	5	-	ns
Write	Write Cycle Time	t_{WC}	70	10k	ns
	Chip enable to end of write	t_{CW}	60	-	ns
	Address setup time	t_{AS}	0	-	ns
	Address valid to end of write	t_{AW}	60	-	ns
	UB#, LB# valid to end of write	t_{BW}	60	-	ns
	Write pulse width	t_{WP}	50	-	ns
	Write recovery time	t_{WR}	0	-	ns
	Write to output high-Z	t_{WHZ}	0	20	ns
	Data to write time overlap	t_{DW}	20	-	ns
	Data hold from write time	t_{DH}	0	-	ns
	End write to output low-Z	t_{OW}	5	-	ns
Page	Maximum cycle time	$t_{MRC}^{*1)}$	-	10k	ns
	Page mode cycle time	$t_{PC}^{*1)}$	25	-	ns
	Page mode address access time	$t_{PAA}^{*1)}$	-	25	ns

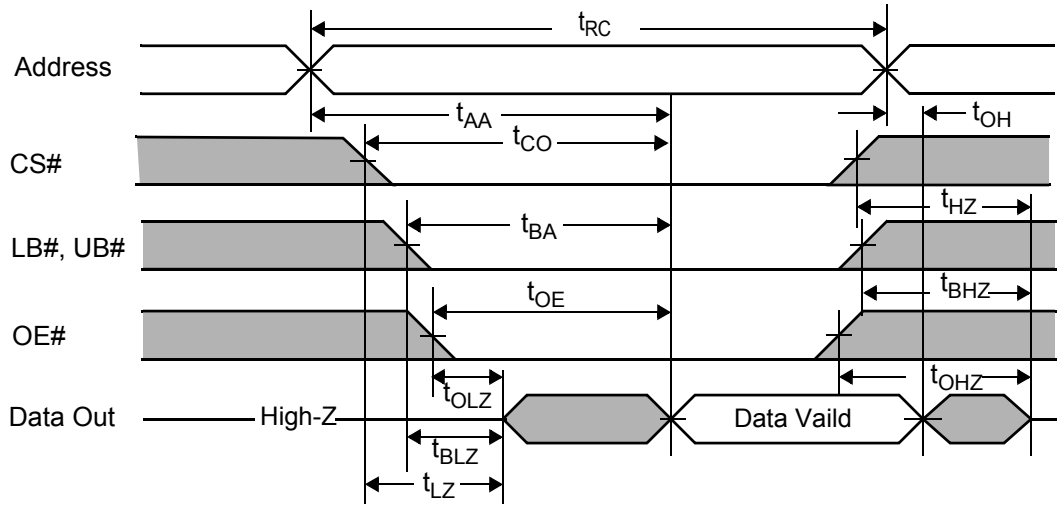
NOTES
1. These parameters are not supported in EM7644SP16RP & EM7644SP16SP.

TIMING DIAGRAMS

READ CYCLE (1) (Address controlled, CS#=OE#=V_{IL}, ZZ#=WE#=V_{IH}, UB# or/and LB#=V_{IL})



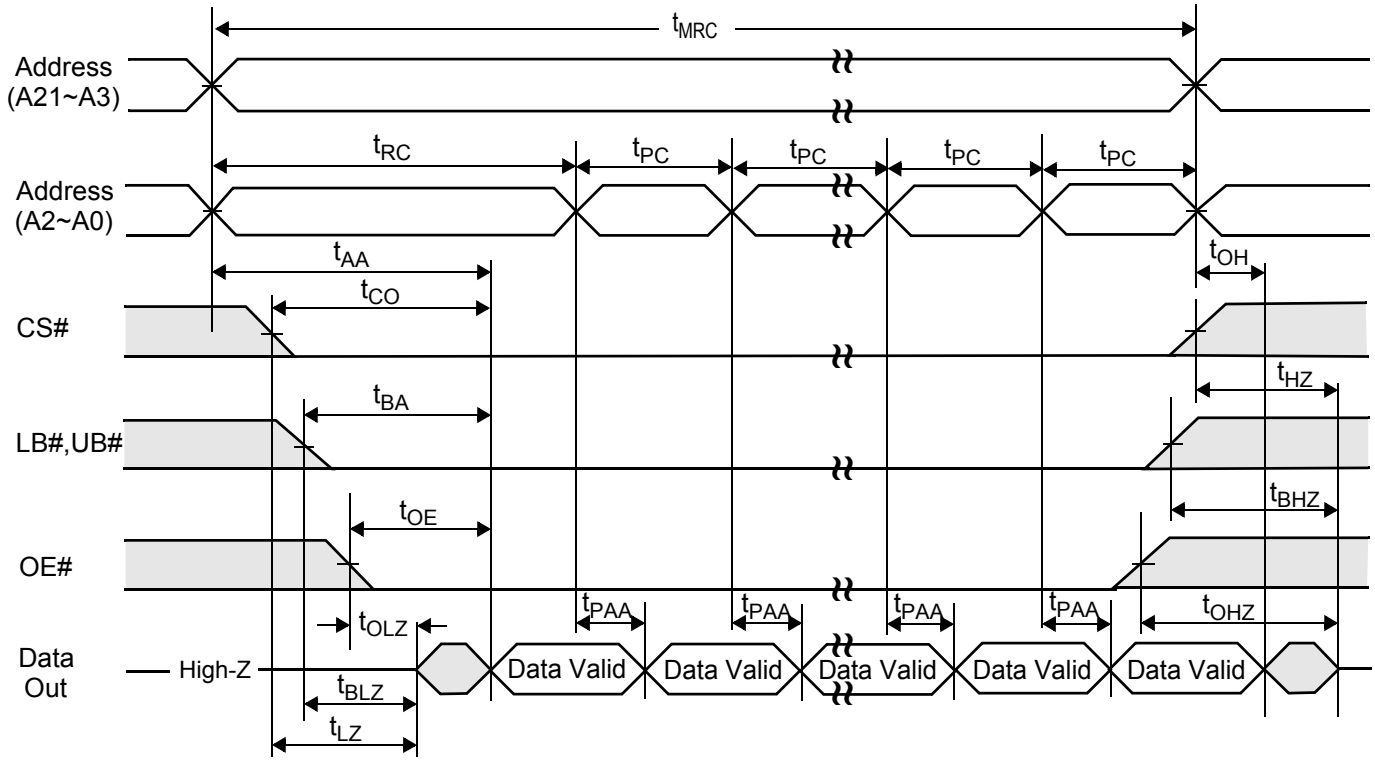
READ CYCLE (2) (ZZ#=WE#=V_{IH})



NOTES (READ CYCLE)

1. t_{HZ} , t_{BHZ} and t_{OHZ} are defined as the time at which the outputs achieve the open circuit conditions and are not referenced to output voltage levels.
2. Do not Access device with cycle timing shorter than t_{RC} for continuous periods > 10us.

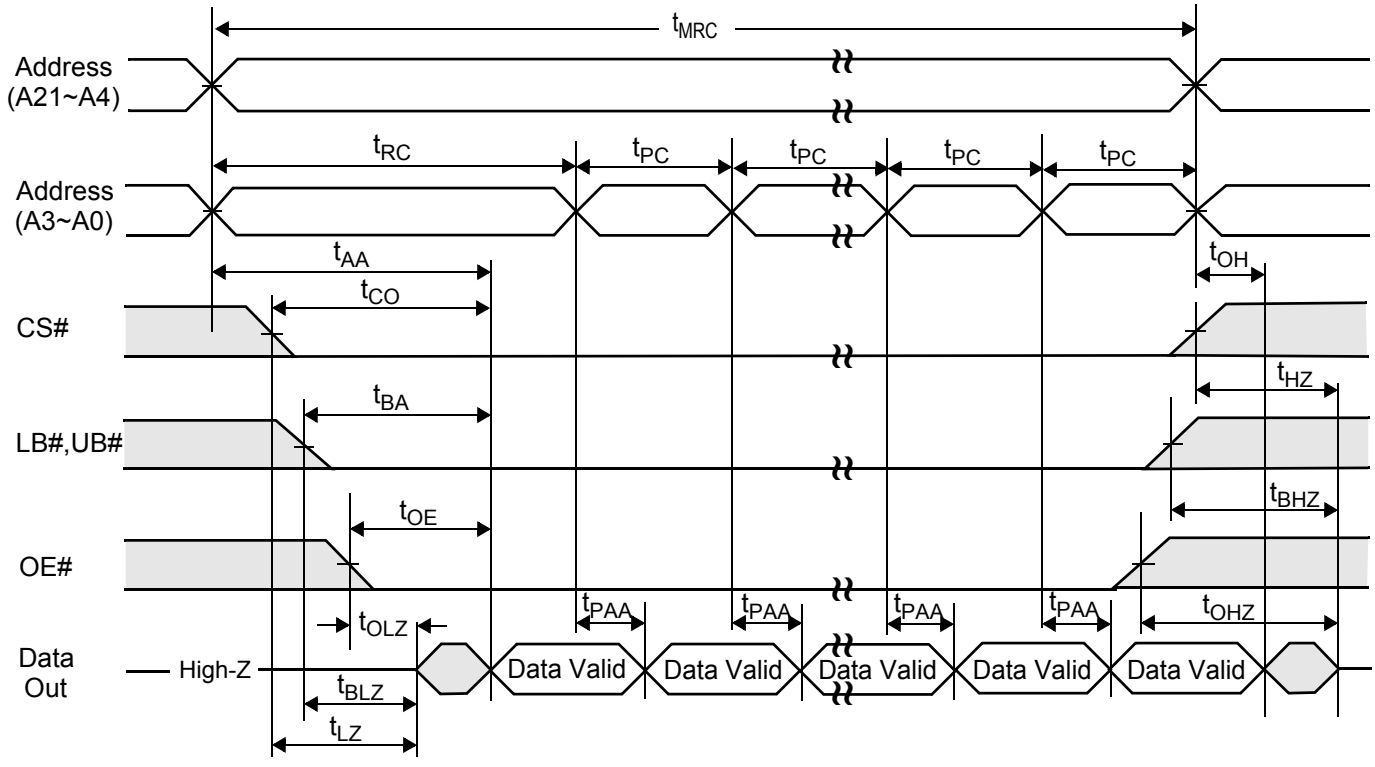
PAGE READ CYCLE (1) (ZZ#=WE#=V_{IH}, 8 Words access)



NOTES (READ CYCLE)

1. t_{HZ} , t_{BHZ} and t_{OHZ} are defined as the time at which the outputs achieve the open circuit conditions and are not referenced to output voltage levels.
2. Do not Access device with cycle timing shorter than t_{RC} for continuous periods > 10us.
3. This page read cycle(8 page mode) is supported in EM7644SP16LP & EM7644SP16MP.

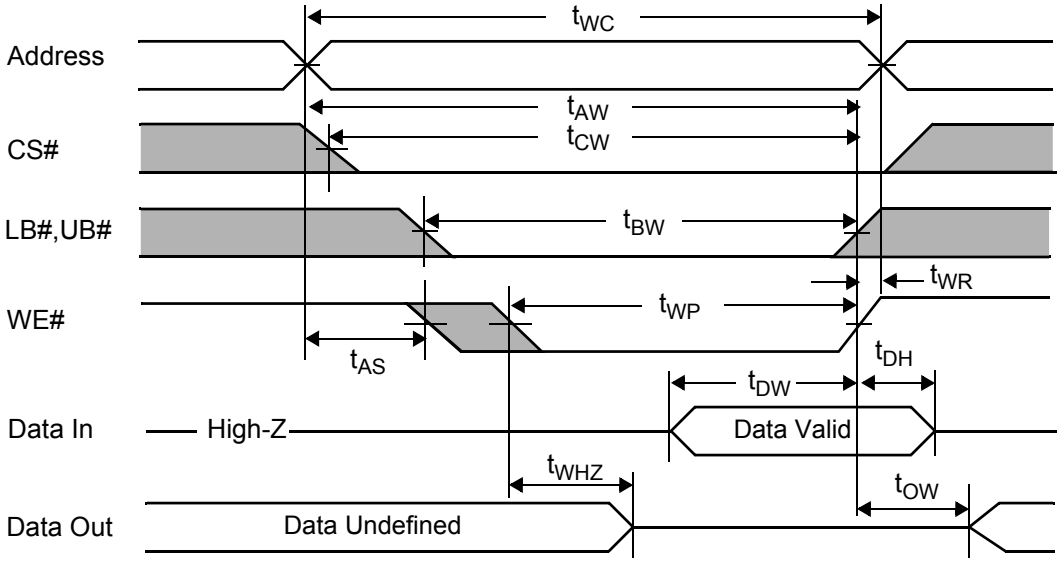
PAGE READ CYCLE (2) (ZZ#=WE#=V_{IH}, 16 Words access)



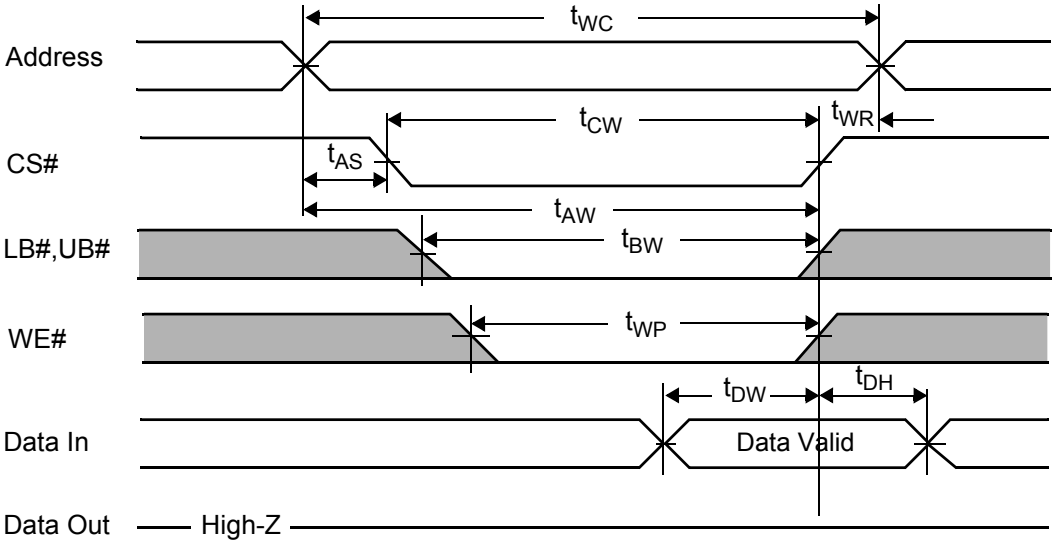
NOTES (READ CYCLE)

1. t_{HZ} , t_{BHZ} and t_{OHZ} are defined as the time at which the outputs achieve the open circuit conditions and are not referenced to output voltage levels.
2. Do not Access device with cycle timing shorter than t_{RC} for continuous periods > 10us.
3. This page read cycle(16 page mode) is supported in EM7644SP16NP & EM7644SP16PP.

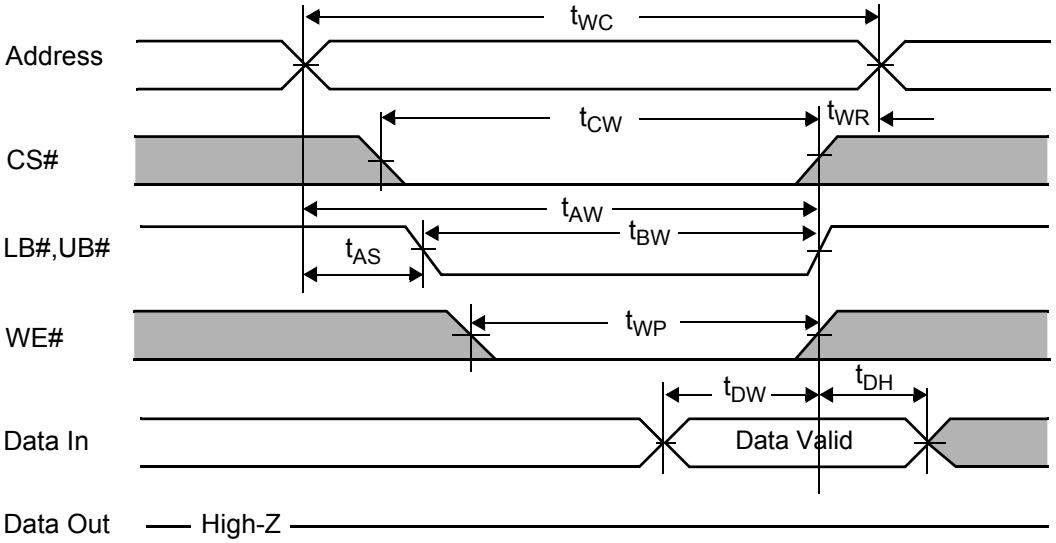
WRITE CYCLE (1) (WE# controlled, ZZ#=V_{IH})



WRITE CYCLE (2) (CS# controlled, ZZ#=V_{IH})



WRITE CYCLE (3) (UB#/LB# controlled, ZZ#=V_{IH})

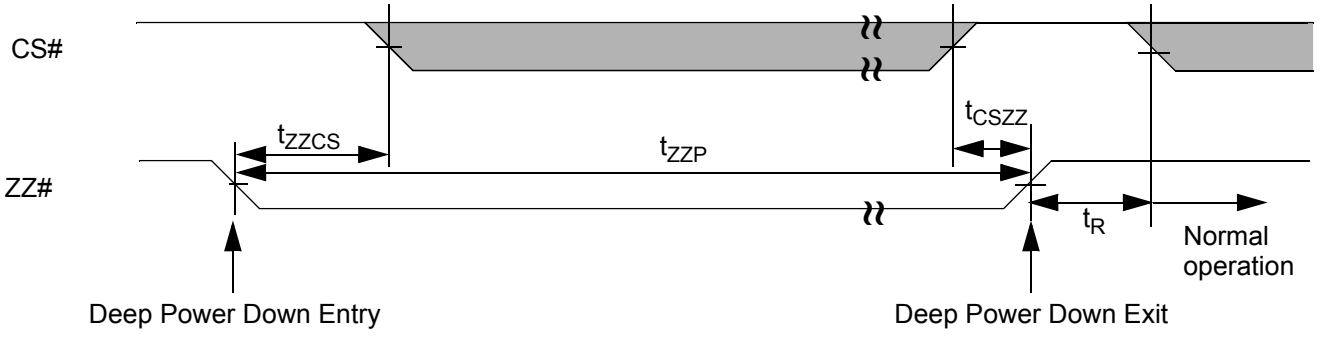


NOTES (WRITE CYCLE)

1. A write occurs during the overlap(t_{WP}) of low CS#, low WE# and low UB# or LB#. A write begins at the last transition among low CS# and low WE# with asserting UB# or LB# low for single byte operation or simultaneously asserting UB# and LB# low for word operation. A write ends at the earliest transition among high CS# and high WE#. The t_{WP} is measured from the beginning of write to the end of write.
2. t_{CW} is measured from CS# going low to end of write.
3. t_{AS} is measured from the address valid to the beginning of write.
4. t_{WR} is measured from the end of write to the address change. t_{WR} applied in case a write ends as CS# or WE# going high.
5. Do not access device with cycle timing shorter than t_{WC} for continuous periods > 10us.

LOW POWER MODES

Deep Power Down Mode Entry/Exit



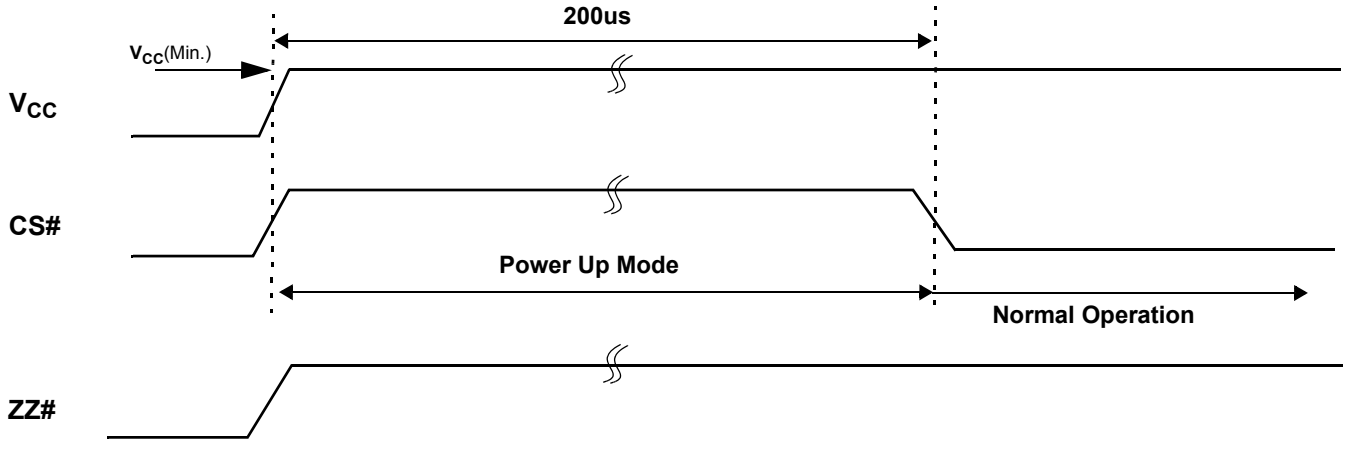
NOTES (DEEP POWER DOWN)
1. During Deep Power Down mode, all referesh related activity are disabled.
2. This DPD mode is supported in EM7644SP16LP, EM7644SP16NP & EM7644SP16RP.

Parameter	Description	Min.	Max.	Units
t_{ZZCS}	ZZ# low to CS# low	0	-	ns
t_{CSZZ}	CS# high to ZZ# high	0	-	ns
t_R	Operation Recovery Time	200	-	us
t_{ZZP}	ZZ# pulse width	20	-	ns

Low Power Mode Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Deep Power Down Current	I_{ZZ}	ZZ# ≤ 0.2V, Other inputs = 0 ~ V_{CCQ} (Max. condition : V_{CC}=1.95V @ 85°C)	-	-	10	uA

TIMING WAVEFORM OF POWER UP



NOTE (POWER UP)

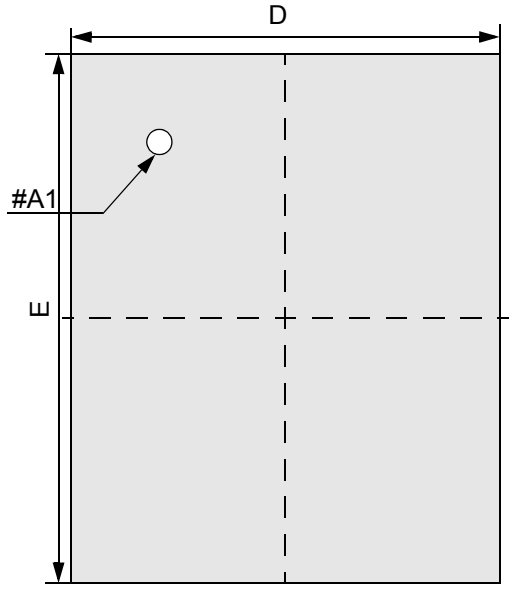
1. After Vcc reaches Vcc(Min.) , wait 200us with CS# high. Then you get into the normal operation.
2. ZZ# pin is replaced to NC pin in EM7644SP16MP, EM7644SP16PP, EM7644SP16SP.

Unit: millimeters

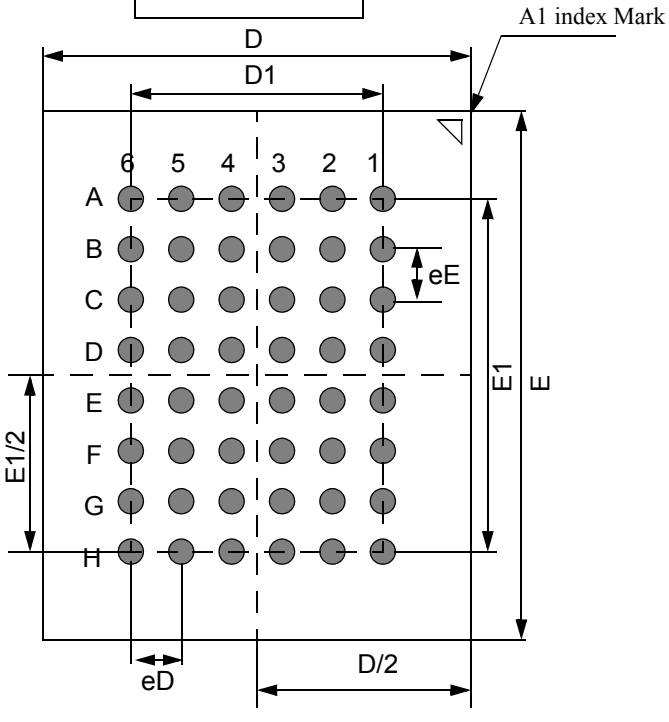
PACKAGE DIMENSION

48 Ball Fine Pitch BGA (0.75mm ball pitch)

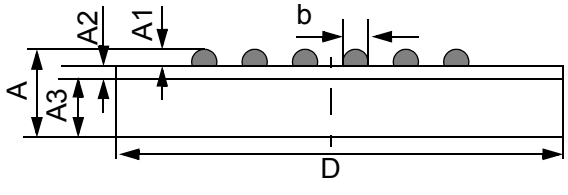
Top View



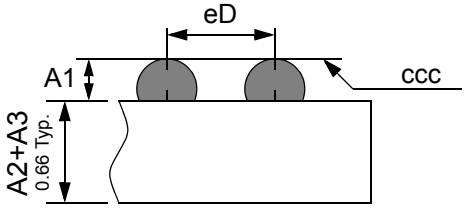
Bottom View



Side View



Detail A



	Min	Typ	Max
A	-	-	1.00
A1	0.22	-	0.32
A2	-	0.21	-
A3	-	0.45	-
b	0.32	-	0.42
D	5.90	6.00	6.10
E	6.90	7.00	7.10
D1	-	3.75	-
E1	-	5.25	-
eE	-	0.75	-
eD	-	0.75	-
ccc	-	-	0.08

NOTES.

1. Bump counts : 48(8row x 6column)
2. Bump pitch : (x,y)=(0.75x0.75) (typ.)
3. All tolerance are +/-0.050 unless otherwise specified.
4. Typ : Typical
5. ccc is coplanarity : 0.08(Max)

MEMORY FUNCTION GUIDE

EM X XX X X X XX X X X - XX XX X

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2. Device Type
3. Density
4. Function
5. Technology
6. Operating Voltage
7. Organization
8. Version
9. Option
10. Package
11. Speed
12. Power
13. Temperature

1. Memory Component

2. Device Type

6	----------	Low Power SRAM
7	----------	STRAM
C	----------	CellularRAM

3. Density

4	----------	4M
8	----------	8M
16	----------	16M
32	----------	32M
64	----------	64M
28	----------	128M

4. Function

2	----------	Multiplexed async.
3	----------	Multiplexed sync.
4	----------	Demultiplexed async.
5	----------	Multiplexed sync.
6	----------	Demultiplexed sync.

5. Technology

S	----------	Single Transistor

6. Operating Voltage

V	----------	3.3V
U	----------	3.0V
S	----------	2.5V
R	----------	2.0V
P	----------	1.8V
L	----------	1.5V

7. Organization

8	----------	X8 bit
16	----------	X16 bit
32	----------	X32 bit

8. Version

Blank	----------	Mother die
A	----------	2 nd generation
B	----------	3 rd generation
C	----------	4 th generation
D	----------	5 th generation

9. Option

Blank	----------	No optional mode
J	----------	Non-RBC
K	----------	RBC
L	----------	8 page mode / DPD
M	----------	8 page mode / Non-DPD
N	----------	16 page mode / DPD
P	----------	16 page mode / Non-DPD
R	----------	Non-page mode / DPD
S	----------	Non-page mode / Non-DPD

10. Package

Blank	----------	Wafer
S	----------	32 sTSOP1
T	----------	32 TSOP1
U	----------	44 TSOP2
P	----------	48 FPBGA
Z	----------	52 FPBGA
Y	----------	54 FPBGA
W	----------	60 FPBGA
V	----------	90 FPBGA

11. Speed(@async.)

45	----------	45ns
55	----------	55ns
60	----------	60ns
70	----------	70ns
85	----------	85ns
90	----------	90ns
10	----------	100ns
12	----------	120ns

12. Power

LL	----------	Low Low Power
LF	----------	Low Low Power(Pb-free & Green)
L	----------	Low Power
S	----------	Standard Power

13. Temperature

Blank	----------	Extended (-25℃ ~ 85℃)
W	----------	Wireless (-30℃ ~ 85℃)
I	----------	Industrial (-40℃ ~ 85℃)